I THE UNITED STATES PATENT AND TRADEMARK OFFICE

**RAEDER** 

Examiner:

Nguyen, D.

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Title:

POLISHING UNIFORMITY VIA PAD CONDITIONING

CERTIFICATE UNDER 37 CFR 1.8: The undersigned hereby certifies that this communication is being deposited in the United States Postal Service, as first class mail, in an envelope addressed to: Assistant Commissioner for Patents, Washington, D.C. 20231, on November 30, 2001.

## OFFICE ACTION RESPONSE

**Assistant Commissioner for Patents** Washington, D.C. 20231

Sir:

In response to the Office Action dated August 31, 2001, please consider the following amendments and response in connection with the above application.

## In the Drawings

Please find replacement Figure 2 with required correction to reference character.

## In the Specification

Please replace the following paragraphs as follows (attached to this Response find marked-up revision to the Specification):

On pages 7-8, lines 18-22 and 1-6 respectively:

FIG. 1 shows a top view and FIG. 2 shows a side view of a CMP arrangement 100, according to another example embodiment of the present invention. The CMP arrangement includes a polishing table 210 having a polishing pad 140. The polishing table 210 is capable of rotation, such as shown by directional arrow 141. A wafer carrier 130 is arranged over the pad

